

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/603,219	RAHUT ET AL.	
Examiner	Art Unit	
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(Legal Instruments Examiner) (Date)						VUTHE SIEK PRIMARY EXAMINER (Primary Examiner) (Date)								O.G. Print Claim(s) 1				O.G. Print Fig.		
	Claims renumbered in the same or						ne ord	er as presented by applicant								☐ T.D. ☐ R.1.47				
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